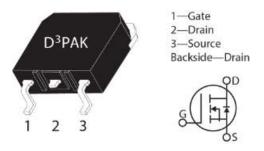


### MSC017SMA120S Silicon Carbide N-Channel Power MOSFET

## **Product Overview**

The silicon carbide (SiC) power MOSFET product line from Microsemi increases the performance over silicon MOSFET and silicon IGBT solutions while lowering the total cost of ownership for high-voltage applications. The MSC017SMA120S device is a 1200 V, 17 m $\Omega$  SiC MOSFET in a TO-268 (D3PAK) package.



#### **Features**

The following are key features of the MSC017SMA120S device:

- Low capacitances and low gate charge
- Fast switching speed due to low internal gate resistance (ESR)
- Stable operation at high junction temperature, T<sub>J(max)</sub> = 175 °C
- · Fast and reliable body diode
- Superior avalanche ruggedness
- RoHS compliant

#### **Benefits**

The following are benefits of the MSC017SMA120S device:

- High efficiency to enable lighter, more compact system
- Simple to drive and easy to parallel
- Improved thermal capabilities and lower switching losses
- Eliminates the need for external freewheeling diode
- Lower system cost of ownership

#### **Applications**

The MSC017SMA120S device is designed for the following applications:

- PV inverter, converter, and industrial motor drives
- Smart grid transmission and distribution
- · Induction heating and welding
- H/EV powertrain and EV charger
- Power supply and distribution



# **Device Specifications**

This section shows the specifications of the MSC017SMA120S device.

# **Absolute Maximum Ratings**

The following table shows the absolute maximum ratings of the MSC017SMA120S device.

**Table 1 • Absolute Maximum Ratings** 

Symbol	Parameter	Ratings	Unit
V <sub>DSS</sub>	Drain source voltage	1200	V
I <sub>D</sub>	Continuous drain current at T <sub>C</sub> = 25 °C	100	А
	Continuous drain current at T <sub>C</sub> = 100 °C	71	
I <sub>DM</sub>	Pulsed drain current <sup>1</sup>	280	
V <sub>GS</sub>	Gate-source voltage	23 to -10	V
P <sub>D</sub>	Total power dissipation at T <sub>C</sub> = 25 °C	357	w
	Linear derating factor	3.33	W/°C

#### Note:

1. Repetitive rating: pulse width and case temperature limited by maximum junction temperature.

The following table shows the thermal and mechanical characteristics of the MSC017SMA120S device.

**Table 2 • Thermal and Mechanical Characteristics** 

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>ÐJC</sub>	Junction-to-case thermal resistance		0.28	0.42	°C/W
T <sub>J</sub>	Operating junction temperature	-55		175	°C
T <sub>STG</sub>	Storage temperature	<b>-</b> 55		150	
TL	Soldering temperature for 10 seconds (1.6 mm from case)			300	
Wt	Package weight		0.14		OZ
			4.0		g



### **Electrical Performance**

The following table shows the static characteristics of the MSC017SMA120S device.  $T_J$  = 25 °C unless otherwise specified.

**Table 3 • Static Characteristics** 

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V, I}_{D} = 100 \mu\text{A}$	1200			V
R <sub>DS(on)</sub>	Drain-source on resistance <sup>1</sup>	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 40 A		17.6	22	mΩ
V <sub>GS(th)</sub>	Gate-source threshold voltage	$V_{GS} = V_{DS}, I_{D} = 4.5 \text{ mA}$	1.9	2.7		V
$\Delta V_{GS(th)}/\Delta T_J$	Threshold voltage coefficient	$V_{GS} = V_{DS}$ , $I_D = 4.5 \text{ mA}$		-4.6		mV/°C
I <sub>DSS</sub>	Zero gate voltage drain current	V <sub>DS</sub> , = 1200 V, V <sub>GS</sub> = 0 V			100	μΑ
		V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V T <sub>J</sub> = 125 °C			500	
I <sub>GSS</sub>	Gate-source leakage current	V <sub>GS</sub> = 20 V/–10 V			±100	nA

#### Note:

1. Pulse test: pulse width  $< 380 \mu s$ , duty cycle < 2%.

The following table shows the dynamic characteristics of the MSC017SMA120S device.  $T_J$  = 25 °C unless otherwise specified.

**Table 4 • Dynamic Characteristics** 

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
C <sub>iss</sub>	Input capacitance	V <sub>GS</sub> = 0 V, V <sub>DD</sub> = 1000 V V <sub>AC</sub> = 25 mV, f = 1 MHz		5280		pF
C <sub>rss</sub>	Reverse transfer capacitance	V <sub>AC</sub> = 23 mV, j = 1 mm2		12		
C <sub>oss</sub>	Output capacitance	-		265		
Q <sub>g</sub>	Total gate charge	$V_{GS} = -5 \text{ V/20 V, } V_{DD} = 800 \text{ V}$ $I_D = 40 \text{ A}$		249		nC
$Q_{gs}$	Gate-source charge			63		
Q <sub>gd</sub>	Gate-drain charge			32		
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD}$ = 800 V, $V_{GS}$ = -5 V/20 V, $I_{D}$ = 50 A, $R_{g(ext)}$ = 4.0 $\Omega$ , Freewheeling diode = MSC017SMA120S ( $V_{GS}$ = -5 V)		52		ns
t <sub>f</sub>	Voltage fall time			21		
t <sub>d(off)</sub>	Turn-off delay time			49		



Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
t <sub>r</sub>	Voltage rise time			16		
E <sub>on</sub>	Turn-on switching energy			1677		μ
E <sub>off</sub>	Turn-off switching energy			395		
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD} = 800 \text{ V}, V_{GS} = -5 \text{ V}/20 \text{ V},$		49		ns
t <sub>f</sub>	Voltage fall time	$I_D = 50 \text{ A}, R_{g(ext)} = 4.0 \Omega$ Freewheeling diode = MSC050SDA120B		19		
t <sub>d(off)</sub>	Turn-off delay time			49		
t <sub>r</sub>	Voltage rise time			14		
E <sub>on</sub>	Turn-on switching energy			1329		μ
E <sub>off</sub>	Turn-off switching energy			429		
ESR	Equivalent series resistance	f = 1 MHz, 25 mV, drain short		0.71		Ω
SCWT	Short circuit withstand time	V <sub>DS</sub> = 960 V, V <sub>GS</sub> = 20 V		3		μs
E <sub>AS</sub>	Avalanche energy, single pulse	V <sub>DS</sub> = 150 V, I <sub>D</sub> = 30 A		3500		mJ

The following table shows the body diode characteristics of the MSC017SMA120S device.  $T_J$  = 25 °C unless otherwise specified.

**Table 5 • Body Diode Characteristics** 

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V <sub>SD</sub>	Diode forward voltage	I <sub>SD</sub> = 40 A, V <sub>GS</sub> = 0 V		3.5		V
		$I_{SD} = 40 \text{ A}, V_{GS} = -5 \text{ V}$		3.9		V
t <sub>rr</sub>	Reverse recovery time	$I_{SD}$ = 50 A, $V_{GS}$ = -5 V, Drive Rg = 4 $\Omega$ $V_{DD}$ = 800 V, dl/dt = -2500 A/ $\mu$ s		40		ns
Q <sub>rr</sub>	Reverse recovery charge			490		nC
I <sub>RRM</sub>	Reverse recovery current			22		Α



# **Typical Performance Curves**

This section shows the typical performance curves of the MSC017SMA120S device.

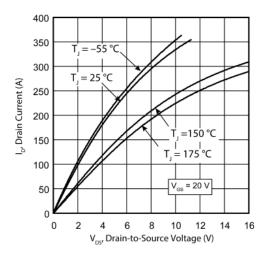


Figure 1 • Drain Current vs. V<sub>DS</sub>

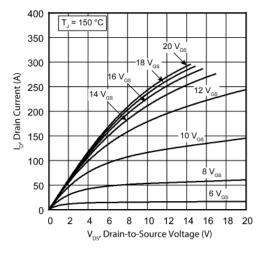


Figure 3 • Drain Current vs. V<sub>DS</sub>

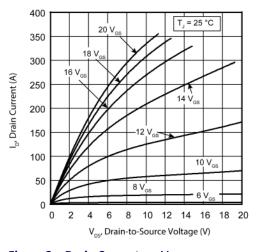


Figure 2 • Drain Current vs. V<sub>DS</sub>

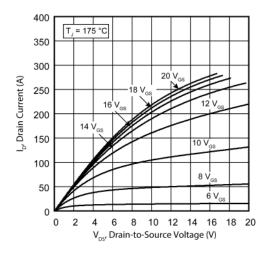


Figure 4 • Drain Current vs. V<sub>DS</sub>



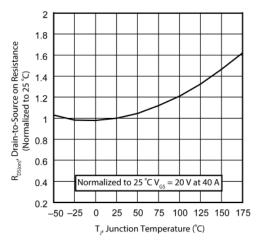


Figure 5 • RDS(on) vs. Junction Temperature

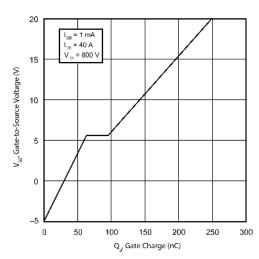


Figure 6 • Gate Charge Characteristics

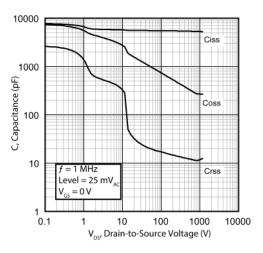


Figure 7 • Capacitance vs. Drain-to-Source Voltage

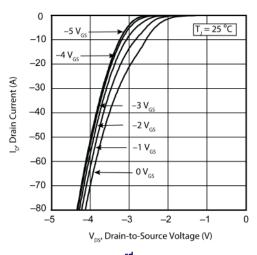


Figure 8 • I<sub>D</sub> vs. V<sub>DS</sub> 3<sup>rd</sup> Quadrant Conduction

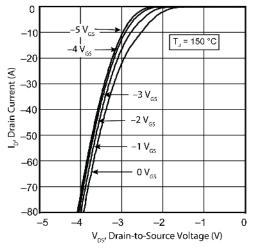


Figure 9 • I<sub>D</sub> vs. V<sub>DS</sub> 3<sup>rd</sup> Quadrant Conduction

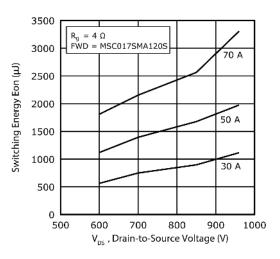


Figure 10 • Switching Energy Eon vs. V<sub>DS</sub> & I<sub>D</sub>



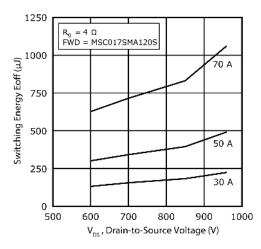


Figure 11 • Switching Energy Eoff vs. V<sub>DS</sub> & I<sub>D</sub>

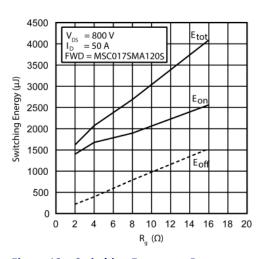


Figure 12 • Switching Energy vs. Rg

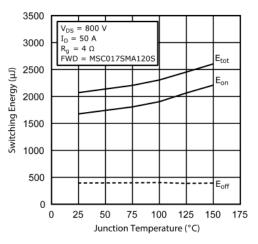


Figure 13 • Switching Energy vs. Temperature

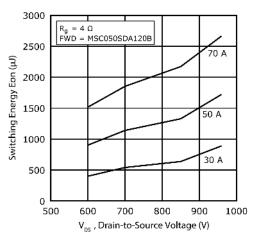


Figure 14 • Switching Energy Eon vs. V<sub>DS</sub> & I<sub>D</sub>

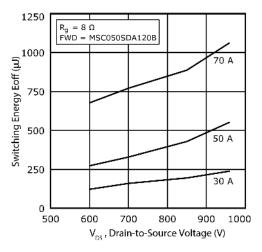


Figure 15 • Switching Energy Eoff vs. V<sub>DS</sub> & I<sub>D</sub>

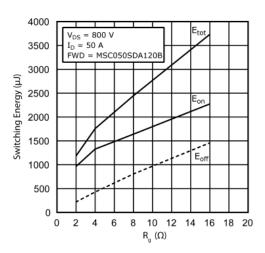
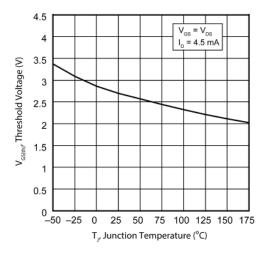


Figure 16 • Switching Energy vs. R<sub>g</sub>





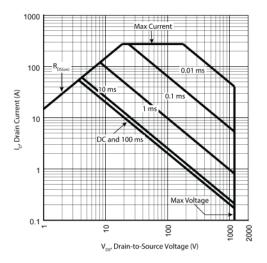


Figure 17 • Threshold Voltage vs. Junction Temp.

Figure 18 • Forward Safe Operating Area

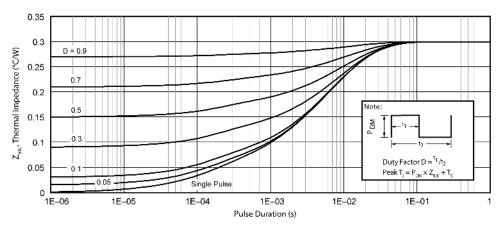


Figure 19 • Maximum Transient Thermal Impedance



# **Package Specification**

This section shows the package specification of the MSC017SMA120S device.

# **Package Outline Drawing**

The following figure illustrates the TO-268 package outline of the MSC017SMA120S device.

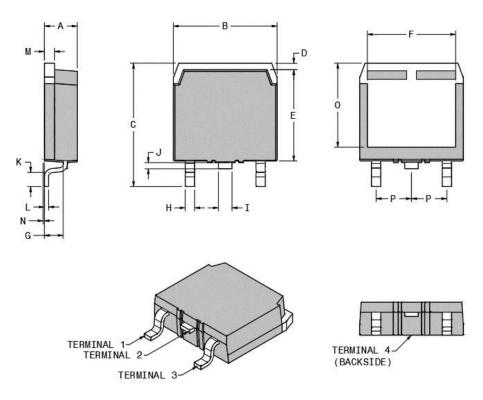


Figure 20 • Package Outline Drawing

The following table shows the TO-268 dimensions and should be used in conjunction with the package outline drawing.

Table 6 • TO-268 Dimensions

Symbol	Min (mm)	Max (mm)	Min (in.)	Max (in.)
А	4.90	5.10	0.193	0.201
В	15.85	16.20	0.624	0.638
С	18.70	19.10	0.736	0.752
D	1.00	1.25	0.039	0.049
Е	13.80	14.00	0.543	0.551
F	13.30	13.60	0.524	0.535



Symbol	Min (mm)	Max (mm)	Min (in.)	Max (in.)			
G	2.70	2.90	0.106	0.114			
Н	1.15	1.45	0.045	0.057			
1	1.95	2.21	0.077	0.087			
J	0.94	1.40	0.037	0.055			
К	2.40	2.70	0.094	0.106			
L	0.40	0.60	0.016	0.024			
М	1.45	1.60	0.057	0.063			
N	0.00	0.18	0.000	0.007			
0	12.40	12.70	0.488	0.500			
Р	5.45 BSC (nom.)		0.215 BSC (nom.)				
Terminal 1	Gate	Gate					
Terminal 2	Drain						
Terminal 3	Source						
Terminal 4	Drain						





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